





Nondestructive Observation of the Change of Micro texture of Ni-base Superalloys under Creep-Fatigue Loading at Elevated Temperature in the Atmosphere

Hayato Matsuda¹, Hideo Miura² and Ken Suzuki³

- ¹ Dep. of Finemechanics, Grad. School of Eng., Tohoku University
- ² Fracture and Reliability Research Institute, Tohoku University
- ³ Green X-tech Research Center, Tohoku University





Degradation of Integrity of Thin-Film Interfaces in Advanced Electronic Devices Caused by Point Defects and Strain

Hideo Miura¹ and Ken Suzuki²

- ¹ Fracture and Reliability Research Institute, Tohoku University
- ² Green X-tech Research Center, Tohoku University